

## FIN1027

### 3.3V LVDS 2-Bit High Speed Differential Driver

#### General Description

This dual driver is designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. The driver translates LVTTTL signal levels to LVDS levels with a typical differential output swing of 350 mV which provides low EMI at ultra low power dissipation even at high frequencies. This device is ideal for high speed transfer of clock or data.

The FIN1027 can be paired with its companion receiver, the FIN1028, or with any other LVDS receiver.

#### Features

- Greater than 600Mbps data rate
- 3.3V power supply operation
- 0.5ns maximum differential pulse skew
- 1.5ns maximum propagation delay
- Low power dissipation
- Power-Off protection
- Meets or exceeds the TIA/EIA-644 LVDS standard
- Flow-through pinout simplifies PCB layout
- 8-Lead SOIC package saves space

#### Ordering Code:

Order Number	Package Number	Package Description
FIN1027M	M08A	8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### Pin Descriptions

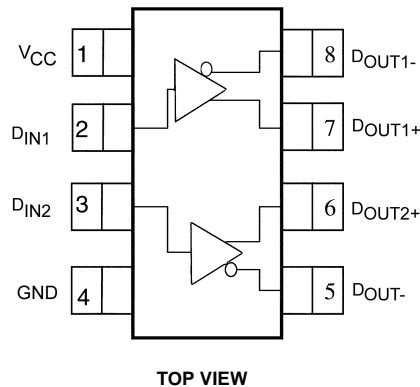
Pin Name	Description
D <sub>IN1</sub> , D <sub>IN2</sub>	LVTTL Data Inputs
D <sub>OUT1+</sub> , D <sub>OUT2+</sub>	Non-inverting Driver Outputs
D <sub>OUT1-</sub> , D <sub>OUT2-</sub>	Inverting Driver Outputs
V <sub>CC</sub>	Power Supply
GND	Ground

#### Function Table

Input	Outputs	
D <sub>IN</sub>	D <sub>OUT+</sub>	D <sub>OUT-</sub>
L	L	H
H	H	L
OPEN	L	H

H = HIGH Logic Level  
L = LOW Logic Level  
X = Don't Care

#### Connection Diagram



**Absolute Maximum Ratings**(Note 1)

Supply Voltage ( $V_{CC}$ )	–0.5V to +4.6V
DC Input Voltage ( $D_{IN}$ )	–0.5V to +6V
DC Output Voltage ( $D_{OUT}$ )	–0.5V to +4.7V
Driver Short Circuit Current ( $I_{OSD}$ )	Continuous
Storage Temperature Range ( $T_{STG}$ )	–65°C to +150°C
Max Junction Temperature ( $T_J$ )	150°C
Lead Temperature ( $T_L$ )	
(Soldering, 10 seconds)	260°C
ESD (Human Body Model)	≥ 6500V
ESD (Machine Model)	≥ 400V

**Recommended Operating Conditions**

Supply Voltage ( $V_{CC}$ )	3.0V to 3.6V
Input Voltage ( $V_{IN}$ )	0 to $V_{CC}$
Operating Temperature ( $T_A$ )	–40°C to +85°C

**Note 1:** The "Absolute Maximum Ratings" are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

**DC Electrical Characteristics**

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 2)	Max	Units
$V_{OD}$	Output Differential Voltage	$R_L = 100\ \Omega$ , See Figure 1	250	350	450	mV
$\Delta V_{OD}$	$V_{OD}$ Magnitude Change from Differential LOW-to-HIGH				25	mV
$V_{OS}$	Offset Voltage		1.125	1.25	1.375	V
$\Delta V_{OS}$	Offset Magnitude Change from Differential LOW-to-HIGH				25	mV
$I_{OFF}$	Power Off Output Current	$V_{CC} = 0V$ , $V_{OUT} = 0V$ or 3.6V			±20	μA
$I_{OS}$	Short Circuit Output Current	$V_{OUT} = 0V$			–8	mA
		$V_{OD} = 0V$			±8	
$V_{IH}$	Input HIGH Voltage		2.0		$V_{CC}$	V
$V_{IL}$	Input LOW Voltage		GND		0.8	V
$I_{IN}$	Input Current	$V_{IN} = 0V$ or $V_{CC}$			±20	μA
$I_{I(OFF)}$	Power-Off Input Current	$V_{CC} = 0V$ , $V_{IN} = 0V$ or 3.6V			±20	μA
$V_{IK}$	Input Clamp Voltage	$I_{IK} = -18\text{ mA}$	–1.5			V
$I_{CC}$	Power Supply Current	No Load, $V_{IN} = 0V$ or $V_{CC}$			12.5	mA
		$R_L = 100\ \Omega$ , $V_{IN} = 0V$ or $V_{CC}$			17	
$C_{IN}$	Input Capacitance			4		pF
$C_{OUT}$	Output Capacitance			6		pF

**Note 2:** All typical values are at  $T_A = 25^\circ\text{C}$  and with  $V_{CC} = 3.3V$ .

## AC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 3)	Max	Units
$t_{PLHD}$	Differential Propagation Delay LOW-to-HIGH	$R_L = 100\ \Omega$ , $C_L = 10\text{pF}$ , See Figure 2 and Figure 3	0.5		1.5	ns
$t_{PHLD}$	Differential Propagation Delay HIGH-to-LOW		0.5		1.5	ns
$t_{TLHD}$	Differential Output Rise Time (20% to 80%)		0.4		1.0	ns
$t_{THLD}$	Differential Output Fall Time (80% to 20%)		0.4		1.0	ns
$t_{SK(P)}$	Pulse Skew $ t_{PLH} - t_{PHL} $				0.5	ns
$t_{SK(LH)}$ , $t_{SK(HL)}$	Channel-to-Channel Skew (Note 4)				0.3	ns
$t_{SK(PP)}$	Part-to-Part Skew (Note 5)				1.0	ns

**Note 3:** All typical values are at  $T_A = 25^\circ\text{C}$  and with  $V_{CC} = 3.3\text{V}$ .

**Note 4:**  $t_{SK(LH)}$ ,  $t_{SK(HL)}$  is the skew between specified outputs of a single device when the outputs have identical loads and are switching in the same direction.

**Note 5:**  $t_{SK(PP)}$  is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits.

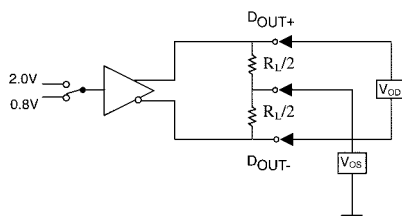
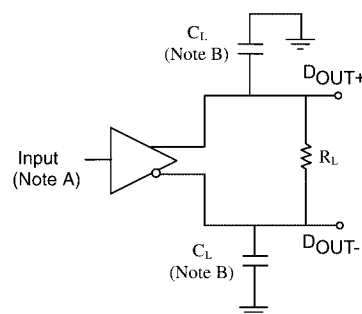


FIGURE 1. Differential Driver DC Test Circuit



**Note A:** All input pulses have frequency = 10 MHz,  $t_R$  or  $t_F = 2\text{ ns}$

**Note B:**  $C_L$  includes all probe and fixture capacitances

FIGURE 2. Differential Driver Propagation Delay and Transition Time Test Circuit

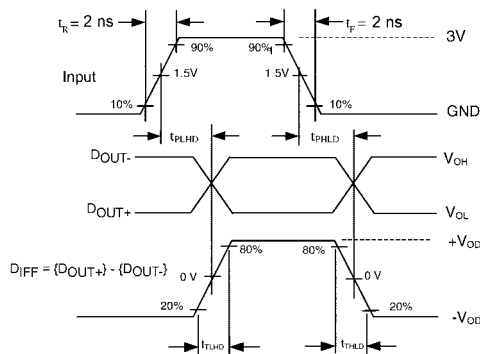
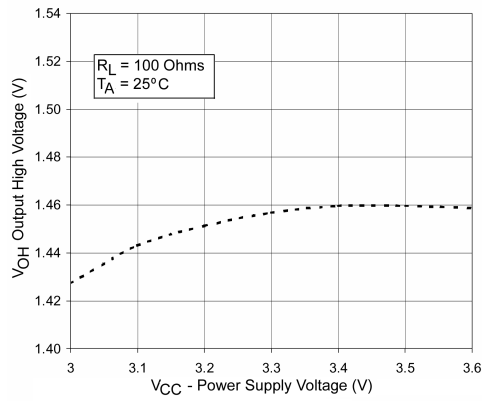
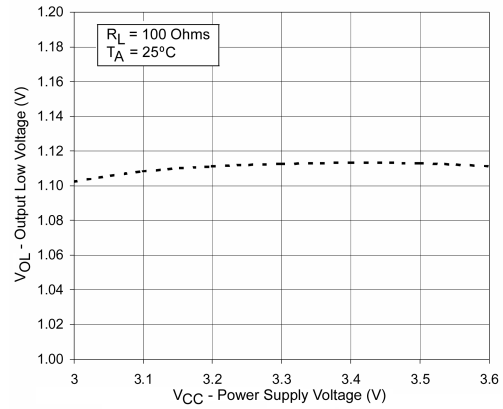


FIGURE 3. AC Waveforms

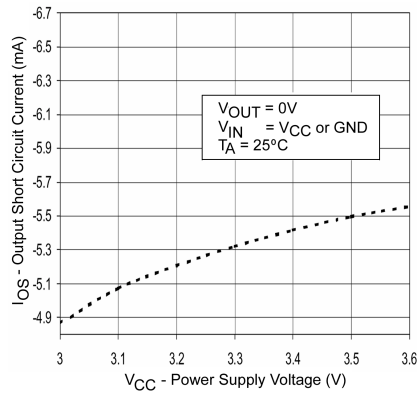
## DC / AC Typical Performance Curves



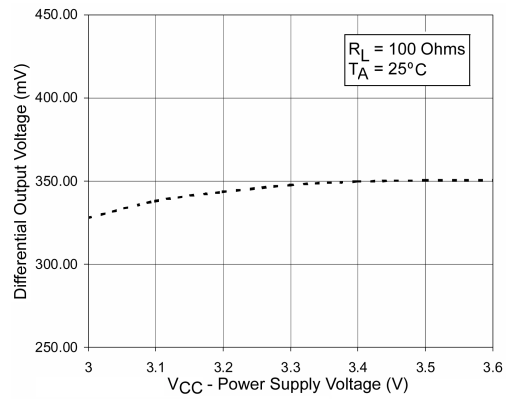
**FIGURE 4. Output High Voltage vs. Power Supply Voltage**



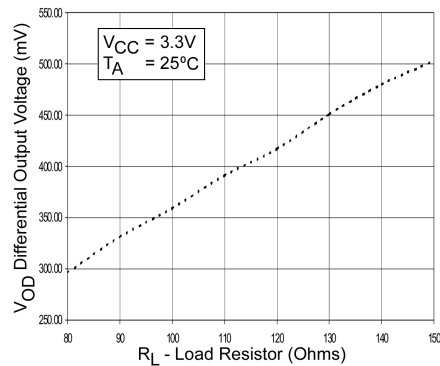
**FIGURE 5. Output Low Voltage vs. Power Supply Voltage**



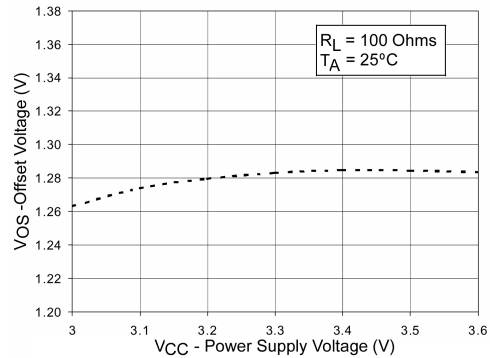
**FIGURE 6. Output Short Circuit Current vs. Power Supply Voltage**



**FIGURE 7. Differential Output Voltage vs. Power Supply Voltage**

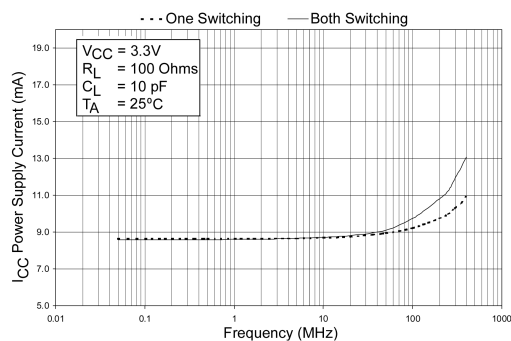


**FIGURE 8. Differential Output Voltage vs. Load Resistor**

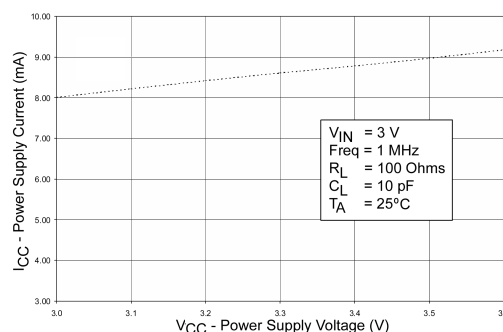


**FIGURE 9. Offset Voltage vs. Power Supply Voltage**

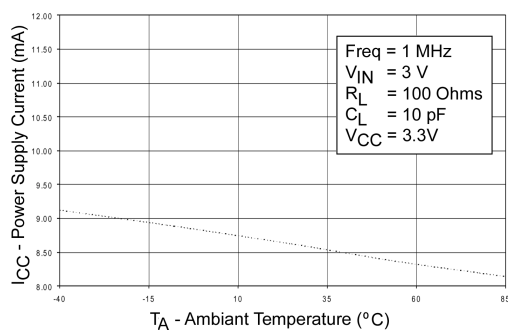
# DC / AC Typical Performance Curves (Continued)



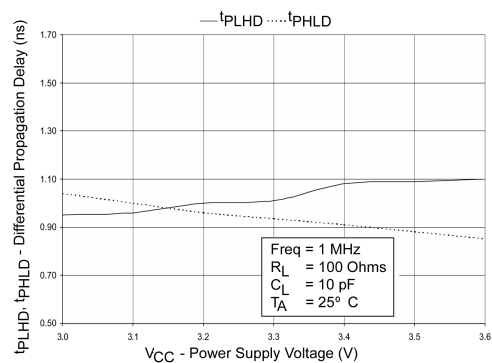
**FIGURE 10. Power Supply Current vs. Frequency**



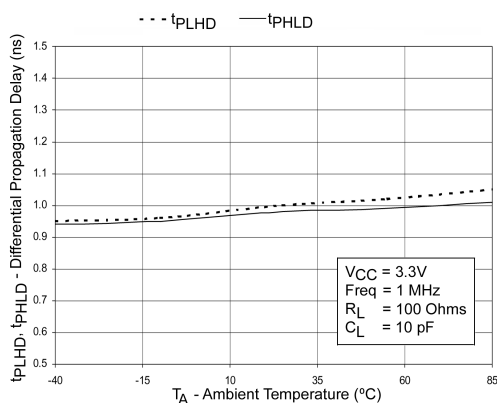
**FIGURE 11. Power Supply Current vs. Power Supply Voltage**



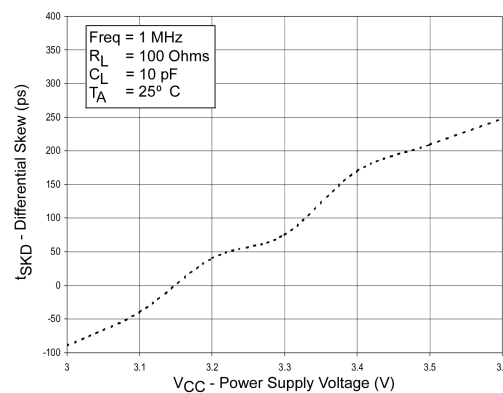
**FIGURE 12. Power Supply Current vs. Ambient Temperature**



**FIGURE 13. Differential Propagation Delay vs. Power Supply**

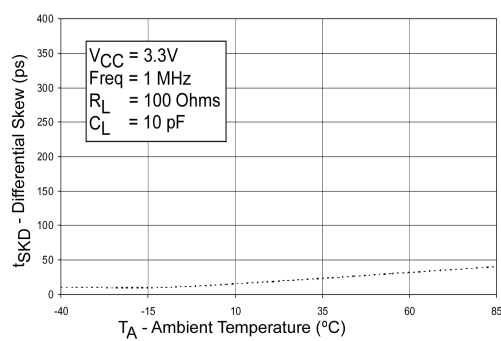


**FIGURE 14. Differential Propagation Delay vs. Ambient Temperature**

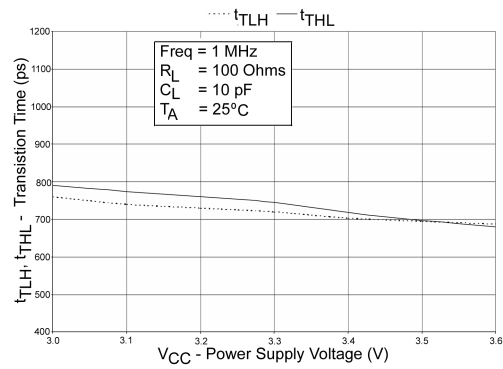


**FIGURE 15. Differential Skew ( $t_{PLH} - t_{PHL}$ ) vs. Power Supply**

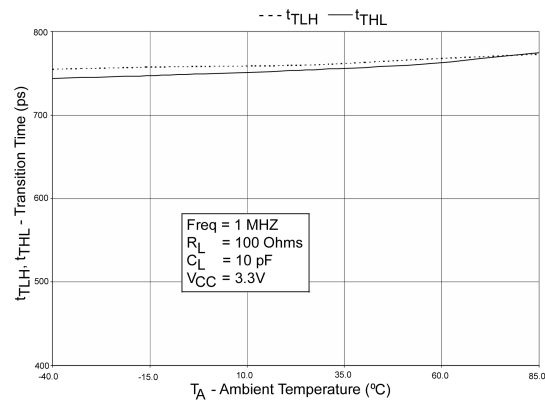
# DC / AC Typical Performance Curves (Continued)



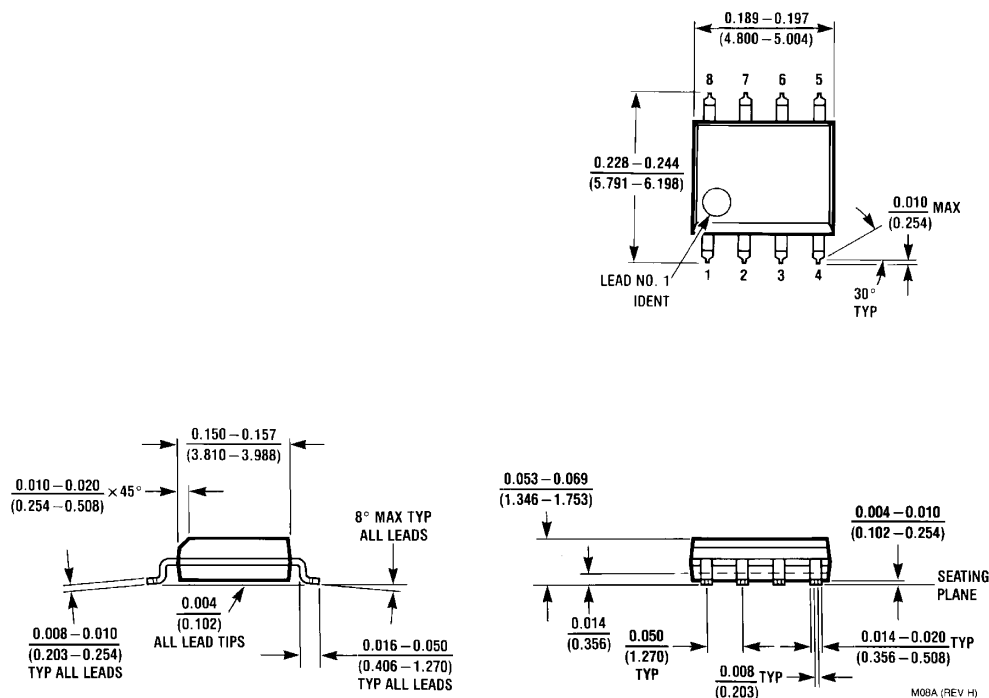
**FIGURE 16. Differential Pulse Skew ( $t_{PLH} - t_{PHL}$ ) vs. Ambient Temperature**



**FIGURE 17. Transition Time vs. Power Supply Voltage**



**FIGURE 18. Transition Time vs. Ambient Temperature**



**8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow  
Package Number M08A**

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